

Notice of References Cited	Application/Control No. 10/560,723	Applicant(s)/Patent Under Reexamination EINSTEIN ET AL.	
	Examiner Sean E. Aeder, Ph.D.	Art Unit 1642	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,812,339	11-2004	Venter et al.	536/24.31
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	J	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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